

THE USE OF JOSEPHSON EFFECT FOR THE DETECTION OF FAR INFRARED AND MICROWAVE RADIATION

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RESUMEN

Se presenta un estudio de las bases teóricas y experimentales para la utilización del efecto Josephson en la observación de objetos astronómicos en un intervalo de frecuencias que incluye al infrarrojo lejano, ondas milimétricas y centimétricas. Se enfatiza la posible aplicación de los micropuentes.

ABSTRACT

The theoretical and experimental bases are presented for the application of the Josephson effect for the detection of electromagnetic radiation of astronomical objects in the far infrared, millimeter and centimeter wavelengths. Emphasis is made on the possible application of microbridges to this effect.

Key words: JOSEPHSON EFFECT — INFRARED DETECTORS.

I. THE BASIC EQUATIONS

The equations describing the "Josephson effects" arise from the consideration of a simple problem, which is the following: if we have two separate superconductors, each one is described by a complex order parameter (Ginzburg and Landau 1950)

$$\Psi_j = \zeta_j \exp(i\alpha_j), \quad j = 1, 2. \quad (1)$$

The real part of Ψ (squared) is proportional to the number of superconducting electrons in each superconductor and the phase α is arbitrary, although once chosen, it has the same value at any point in the superconductor (in the absence of external fields or currents). Now, if the two superconductors are brought together, they will be described by the same complex order parameter; hence the value of the phase will be the same in both. One may ask if there exists an intermediate situation in which, although there are two different order parameters, these are not independent. The answer, of course, is positive and gives rise to the Josephson equations:

$$I = I_0 \sin\phi \quad (2)$$

$$\text{and} \quad d\phi/dt = 2eV/\hbar, \quad (3)$$

where ϕ denotes the difference in the values of the phase for the two superconductors. Both formal and intuitive derivations of these equations can be found in the literature (Josephson 1965). Eq. (2) describes the "D.C. Josephson Effect"; that is, the passage of a zero voltage current between the two superconductors up to a maximum I_0 . Eq. (3) describes the "A.C. Effect", that is, the oscillation of the current due to the presence of a D.C. voltage across the two superconductors.

The equations were first derived (Josephson 1962) in reference to two superconductors, physically separated by a thin barrier, and the first experiments (Shapiro *et al.* 1964) were performed with such a geometry (tunnel junctions). However, subsequent experimental evidence showed that the behavior implied by Eqs. (2) and (3) was manifest in diverse geometries, whose only common feature is the fact that two "bulk" superconductors are

connected through a weak superconductor; that is, a region in which the value of the order parameter is depressed. This region must be small; i. e., of the size of the coherence length in the superconductor. These geometries hardly fulfill the hypothesis implied in the derivation of Eqs. (2) and (3) by the usual methods. New theories were developed to explain the behavior of the weak links, which entail different physical mechanisms to those in the tunnel junctions. However, both tunnel junctions and weak links show the features described by Josephson equations. Hence, we prefer to look at Eqs. (2) and (3) as "phenomenological" equations describing a certain type of phenomena that take place when the phases of the order parameters in two superconductors are not independent.

Consistent with this approach, we can study the current-voltage characteristics of a Josephson device by using a two fluid model, in which we take the weak link as a circuit element, through which we can pass both a normal current (single electrons or quasiparticles) and a supercurrent; i.e., we can write the device current as a sum

$$I(t) = I_s(t) + I_n(t). \quad (4)$$

The normal component has some features in common with currents in metals and semiconductors. The dispersion relation

$$E_k = \sqrt{\epsilon_k^2 + \Delta_k^2} \quad (5)$$

in the superconductor can be thought of as defining a conduction band, analogous to that in semiconductors. The particles occupying states in the band will be accelerated by external forces and scattered by the usual mechanisms. We can write for the normal current

$$I_n(t) = V(t)/R_J, \quad (6)$$

where R_J is a resistance roughly comparable to the resistance R_n in the normal state. An expression for the supercurrent is given by the Josephson relation eq. (2). The maximum zero voltage current can be taken as an experimental parameter. Although the theory predicts a value

$$I_0 \sim \pi\Delta/2eR_n,$$

one observes experimentally, that imperfections in the sample preparation generally yield a value of I_0 different from the theoretical prediction.

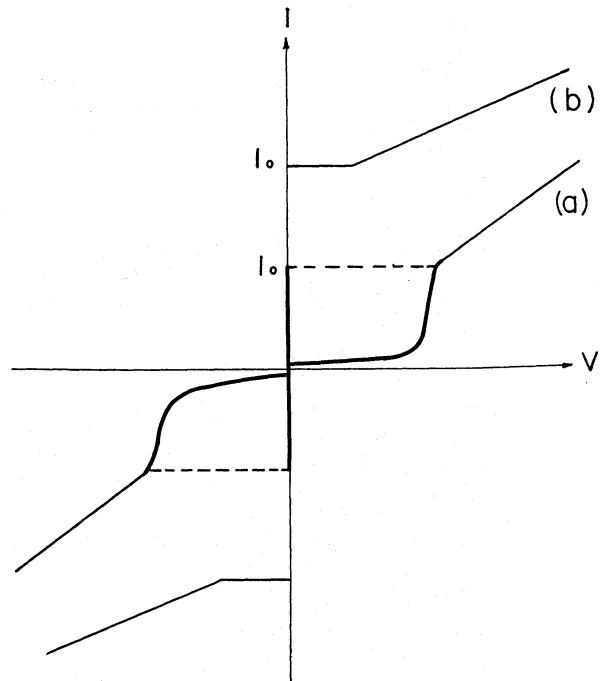


FIG. 1. Typical load curves. Curve (a) is obtained with a tunnel junction, curve (b) with a weak link.

The I-V characteristics of weak links are different from those in tunnel junctions (Waldram *et al.* 1970). See Figure 1. The possibility that these differences might be due to intrinsic capacitance or inductance in the device, was examined by using the two-fluid model approach (McCumber 1968; Stewart 1968). Two idealized situations were considered. The first pictured the link as having associated shunt capacitance and resistance and was driven by a constant current source. Hysteresis was observed in the computed I-V curves. The second case consisted of a weak link with resistive shunt and series inductance, a situation supposedly in keeping with the microbridge or point-contact configurations, whose capacitance is negligible. This was driven from a constant voltage source. No hysteresis was noted,

although variation of the maximum zero-voltage current with inductance was seen. The presence or absence of hysteresis is thus presumed to be an indicator of the capacitive/inductive nature of the device.

These two cases are extremes in the sense that constant voltage of constant current sources are employed. In an experimental situation, one has only a voltage source with a series resistance. The effect of a realistic source on the I-V curves has been studied (Warman and Blackburn 1971, 1972) and the results may be summarized as follows: For an inductive system, the main effect is to produce a negative resistance region, which extends to some voltage determined by the inductance and the ratio $\beta = R_s/R_J$ (source resistance and Josephson device resistance). Beyond this voltage, the current increases with increasing voltage, finally merging with the $\beta = 0$ characteristic.

For a capacitive system with large-source resistance, the features noted by Stewart are observed. In particular, hysteresis caused by the appearance of a rotational branch is seen. As β is decreased, a negative resistance region develops and, at the same time, the rotational branch is displaced upward to higher currents. Below a certain β_{\min} , this rotational solution vanishes and a single reversible I-V characteristic results. We wish to emphasize that, in this regime, the inductive and capacitive models are qualitatively indistinguishable; and that assignment of L or C by curve fitting to experimental data could be misleading.

The negative resistance region implied by our results has been experimentally observed (Buckner *et al.* 1970; Shapiro 1963).

II. WEAK LINKS AS RADIATION DETECTORS

a) *Effect of an Electromagnetic Field on Weak Links.*

As we mentioned before, Eq. (3) implies that a D.C. voltage V_0 applied across a weak link generates an A.C. component of frequency,

$$\omega_0 = 2e V_0 / \hbar.$$

the frequency $2e/\hbar$ is rather high (483.6 MHz/ μ V). If, by means of electromagnetic radiation, we induce an additional A.C. voltage of frequency ω_1 , Eq. (3) becomes

$$\frac{d\Phi}{dt} = \frac{2e}{\hbar} (V_0 + V_1 \cos \omega_1 t) \quad (7)$$

or, integrating,

$$\Phi(t) = \frac{2e}{\hbar} (V_0 t + \frac{1}{\omega_1} \sin \omega_1 t) + \Phi_0. \quad (8)$$

Substituting Eq. (8) in (2), taking $\Phi_0 = 2\pi$ (which corresponds to the maximum zero voltage current) and using the standard relations

$$\cos(x \sin \alpha) = \sum_{n=-\infty}^{\infty} J_n(x) \cos(n\alpha)$$

$$\sin(x \sin \alpha) = \sum_{n=-\infty}^{\infty} J_n(x) \sin(n\alpha),$$

where J_n are Bessel functions of order n ,

$$I(t) = I_0 \sum_{n=-\infty}^{\infty} J_n \left(\frac{2eV_1}{\hbar\omega_1} \right) \cos(\omega_0 + n\omega_1)t. \quad (9)$$

That is, for voltages such that $\omega_0 + n\omega_1 = 0$, there is a D.C. contribution to the current (voltage steps),

$$I_{DC} = I_0 (-1)^n J_n \left(\frac{2eV_1}{\hbar\omega_1} \right) \quad (10)$$

at fixed voltages, which correspond to the harmonics of ω_1 .

If, instead, we induce across the link two A.C. voltages at frequencies ω_1 and ω_2 , a similar derivation gives, instead of Eq. (9),

$$I = I_0 \sum_{n=-\infty}^{\infty} \sum_{m=-\infty}^{\infty} J_n \left(\frac{2eV_1}{\hbar\omega_1} \right) J_m \left(\frac{2eV_2}{\hbar\omega_2} \right) \sin[\omega_0 t + \Phi_0 + n(\omega_1 t + \phi_1) + m(\omega_2 t + \phi_2)] \quad (11)$$

where Φ_0 , Φ_1 , Φ_2 are constants and, instead of Eq. (10), we get as an expression for the maximum zero voltage current,

$$I_{DC} = I_0 J_0 \left(\frac{2eV_1}{\hbar\omega_1} \right) J_0 \left(\frac{2eV_2}{\hbar\omega_2} \right) \quad (12)$$

where we have chosen $\Phi_0 = \pi/2$. Eq. (11) not only implies the occurrence of steps at the harmonic frequencies of ω_1 and ω_2 , but, also, at the mixed frequencies $\omega_1 \pm \omega_2$.

b) Current and Voltage Bias

In an experimental situation, one has the choice to operate the weak link from a voltage or from a current source. This is equivalent to a choice of $\beta = 0$ (perfect voltage source) or $\beta \gg 1$ (in the limit $\beta \rightarrow \infty$ one has a perfect current source). From a practical point of view, it is easier to make a current source (a battery in series with a variable resistor will be enough). Due to the low impedance of a typical weak link ($\sim .1\Omega$), in order to have a true voltage source, one has to have a very low source impedance. Nevertheless, this is certainly possible (Blackford 1971).

However, the radiation induced structure of the I-V characteristic will not be identical for the two cases. The results shown in Eqs. (9) to (11) assume implicitly that one is using a voltage source. That is, we take a given expression for the voltage. We introduce it in Eq. (3), (see Eq. 7). We solve for $\Phi(t)$, and we use this Φ to obtain, through Eq. (2), an expression for the current flowing in the circuit. Eq. (9) shows that this method gives constant voltage steps at the harmonic frequencies

$$\omega_0 = n\omega_1.$$

Let us say that we use a D.C. current source, and we represent the incoming radiation by an A.C. current supply, in series with the bias source. Kirchhoff's law for this circuit is

$$I_0 + I_1 \cos \omega_1 t = I_0 \sin \Phi + \frac{2e}{\hbar} \sigma \frac{d\Phi}{dt}, \quad (13)$$

where this time we take the current as given, and we want to find $\langle \frac{d\Phi}{dt} \rangle$, the average voltage. One has to use numerical methods to solve this equation; but the results show (Waldram *et al.* 1970) constant

voltage steps at both the harmonic and subharmonic frequencies of ω_1 ; i. e., when

$$m\omega_0 = n\omega_1.$$

The subharmonic structure was first observed in weak links (point-contacts or bridges as opposed to tunnel junctions). This has been generally assumed to come from microscopic short circuits across the insulating layer, or from the presence of an inductive reactance in the weak link (see Figure 2). However, the fact that Eq. (13) does not contain an inductive term and yet predicts the subharmonic structure is very puzzling for the author. One possible explanation is that subharmonic structure would appear in Eq. (9), if the Josephson current-phase relation Eq. (2) would not be sinusoidal. By the same token, one can raise the question of how fair is it to represent the incoming radiation by a voltage source (Eq. 7) and not by a current source (Eq. 13).

c) Broad Band Detection

Clearly, the zero voltage current represents a $n = 0$ step for any frequency of the incident radiation.

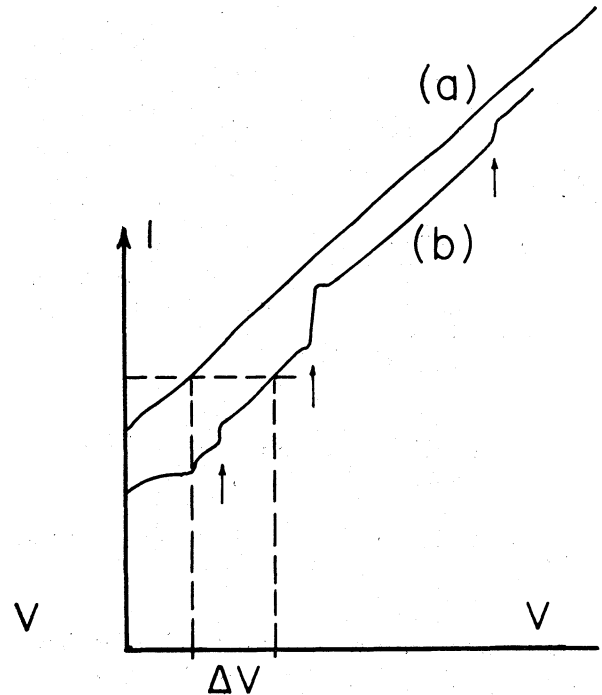


FIG. 2. A weak link load curve with (b) and without applied radiation (a). Both harmonic and subharmonic structures are manifest.

tion. Hence, by monitoring its height, one operates the weak link as a broadband detector. If we take Eq. (10) for $n = 0$ and in the limit of small signals, we get

$$\delta I_0 = -\frac{1}{4} I_0 \left(\frac{2e}{\hbar \omega_1} \right) \delta V_1^2, \quad (14)$$

where δI_0 is the change in critical current due to δV_1 . That is, we get a square law detector (in units of voltage) or a linear response detector (in units of power). A convenient experimental arrangement consists of current biasing the link slightly above the critical current I_0 and modulating the amplitude of the incoming radiation (e.g. with a chopper). Then, one can use a phase sensitive lock-in amplifier to detect the change in voltage, due to the change in the value of I_0 (ΔV in Figure 2).

d) Heterodyne Detection

Of course, one can apply the same biasing scheme to other harmonic steps. We can interpret the voltage steps as zero frequency beats between the A.C. Josephson current and the n th harmonic of the incident radiation. Then, by monitoring the height of the steps, we obtain a heterodyne detector that uses the A.C. Josephson current as a local oscillator. Eq. (10) gives, in the limit of small V_1 ,

$$I_{DC} = \frac{I_0}{n!} \left(\frac{eV_1}{\hbar \omega_1} \right)^n; \quad (15)$$

therefore, monitoring the $n = 1$ step we get a linear detector, the $n = 2$ step a square law detector, and so on. However, the scheme of biasing that is convenient for the $n = 0$ step has some serious drawbacks for the harmonic steps. The most important is its inconvenience for the measurement of small signals, since in order to bias in the region of high differential resistance (that would yield high sensitivity) one needs a finite step height. In the limit of small incident power, only the $n = 0$ step has a finite height.

There are two different ways to overcome this difficulty. The first one is to locate the weak link in a resonant cavity. The theory of the Josephson effect has been extended to include this case (Grimes

et al. 1968). Essentially, what happens is that the cavity is driven by the Josephson A.C. current and, in its turn, it induces steps on the I-V characteristic of the junction at the voltage corresponding to the resonant frequency. One overcomes the above mentioned problem and it is possible to monitor the height of the *cavity induced step*, in the presence of incoming radiation. A heterodyne detector is thus obtained that uses the cavity as a local oscillator (Richards and Sterling 1969).

Finally, the weak link can be operated as a mixer, as suggested by Eqs. (11) and (12). If in Eq. (11) ω_1 is taken very close to ω_2 , $\omega_1 - \omega_2$ can be an intermediate frequency (e.g. 30MHz). Very low noise amplifiers are available at these frequencies and can be used to detect the I-F radiation coming from the step at $\omega_1 - \omega_2$.

e) The Impedance Matching Problem

Every geometry of weak coupled superconductors, that has manifested Josephson-like behavior, has a common feature. The resistance in the I-V characteristic is of the order of 0.1Ω . If we want to use the weak link as a detector in the microwave or infrared regions, this impedance has to be matched to that of a waveguide or light pipe, which is typically of the order of 370Ω . If the incident power on the waveguide is P_0 , the voltage it generates on the weak link (V_1 on Eq. 7) will be, in general, given by

$$V_1 = [4 \frac{Z_1^2 Z_0}{(Z_1 + Z_0)^2} P_0]^{1/2}, \quad (16)$$

where Z_0 , Z_1 are the impedances of the link and the waveguide, respectively. If we use a perfect matching transformer, $Z_1 = Z_0$ and Eq. (16) reduces to

$$V_1^2 = Z_1 P_0. \quad (17)$$

Therefore, even for perfect matching, high junction impedances are desirable. However, the noise due to phase slippage is proportional to the resistance of the weak link. Both factors should be kept in mind.

f) General Features of a Josephson Detector

i) *Frequency Response.* The response of a Josephson detector is limited on the low-frequency

limit by the smallness of the voltage that one is able to detect that is, since

$$2e/\hbar \simeq 484 \text{ MHz}/\mu\text{V},$$

frequencies of the order of 500 KHz will induce steps at $v \sim 1 \text{ nV}$. Experiments have been reported (Kamper and Zimmerman 1971) which use a few KHz. For high frequency, the response is limited by the energy gap. That is, when the frequency ω of the radiation is such that

$$\hbar\omega \sim \Delta g \sim 1.5 - 2 \cdot kT_c,$$

where T_c is the critical temperature of the superconductor, it will induce only quasiparticle tunneling. The higher the frequency the more the behavior of the superconductor will resemble that of a normal metal. However, the energy gap is not a sharp boundary and high sensitivities have been reported for frequencies as high as $4\Delta g$ (Grimes *et al.* 1968). Clearly, a weak link made up of Nb_3Sn ($T_c \sim 18^\circ\text{K}$), will extend its range to twice of one made of Pb ($T_c \sim 9^\circ\text{K}$). Only in this respect (and obvious mechanical properties) will the particular material influence the behavior of a weak link. This range of applicability extends into the far infrared (wavelengths of the order of 100-200 μ).

ii) *Noise*. Several treatments of noise can be found in the literature for diverse geometries in Josephson junctions (Stephen 1969). We shall only sketch some of the more relevant results. The first one concerns the noise introduced in the junction by an external measuring circuit at room temperature. The way this problem has been treated is by adding to the Josephson device circuit equation a fluctuating noise current (white noise) term that has an average value $2kR^{-1}T$. The main effect related to the introduction of this term is a change in the value of the maximum zero voltage current; hence in the height of all the constant voltage steps. As the fluctuations increase, the zero voltage supercurrent is reduced and a supercurrent maximum appears at a *non-zero voltage*. This, in effect, amounts to a rounding of the super-normal transition. Figure 3 shows this rounding-off as a function of the noise (Ambegaokar and Halperin 1969). Further increase in the noise leads to a further reduction of the

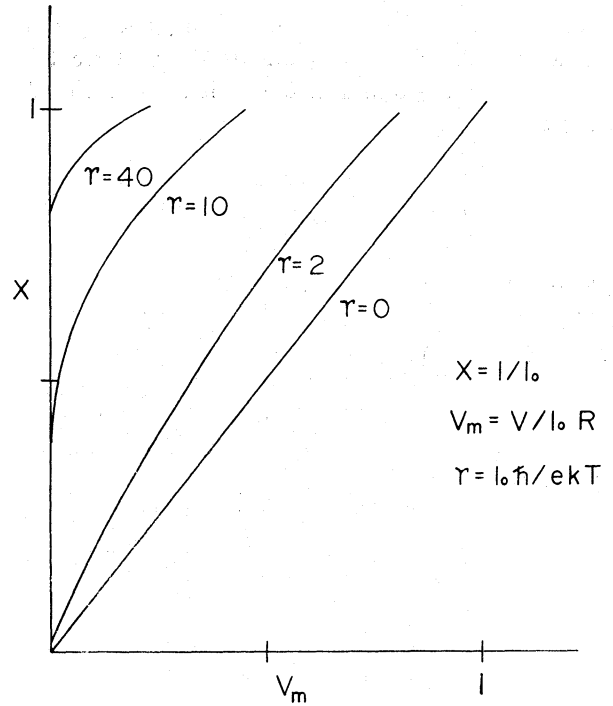


FIG. 3. Effect of noise in the I-V characteristics. Decreasing values of γ correspond to increasing noise.

maximum and to an increase of the voltage at which it appears. In the high noise limit, the supercurrent is given by (Ivanchenko and Zil'berman 1969)

$$\left(\frac{I}{I_0}\right)_{dc} = \frac{z}{2} \frac{2eVD/\hbar}{(2eV/\hbar)^2 + D^2},$$

where I_0 is the supercurrent in the absence of noise, $D = kT_n R (2e\hbar)^2$, $z = \hbar I_0 / 2ekT_n$ (the ratio of the Josephson coupling energy to kT_n) and T_n is the effective noise temperature of the noise source. A different type of noise (shot noise) comes from random fluctuations in the junction when its temperature is low, $kT \ll eV$. This shot noise is equivalent to thermal noise at a certain effective temperature

$$T_{eff} \approx eV/k,$$

or using Josephson relation (3)

$$T_{eff} \approx \hbar\omega/2k$$

If one is working with $\omega \sim 20\text{GHz}$, then $T_{\text{eff}} \sim .5^\circ\text{K}$. We must remark, however, that in most experimental situations these sources of noise are not necessarily dominant. Imperfections in the sample, which are very hard to avoid, have a very strong effect. A typical example is the fact that not all the link undergoes simultaneously the super-normal transition. This effect is particularly noticeable in the powder junction and causes noise through the redistribution of supercurrents and a rapid change in the value of the resistance. Other effects, such as: trapped flux, radiation pickup, pickup noise through the line, and temperature variations in the bath (bubbling in the LHe) also affect strongly the limiting noise.

iii) *Sensitivity and Speed.* The sensitivity performance of the Josephson detectors is rather good. Typical figures for the Noise Equivalent Power are $10^{-13} \text{ W}/\sqrt{\text{Hz}}$ on the broad-band mode (coupled through a cavity) and $10^{-14} \text{ W}/\sqrt{\text{Hz}}$ for the regenerative detector in the IR region. This compares favorably with other existing IR detectors; *e. g.*, the germanium bolometer. The theoretical relaxation time for a Josephson detector is $\sim 10^{-12} \text{ sec}$. and its speed of response has been measured to be faster than 10ns (Grimes *et al.* 1968). This response time means that variations that have very short periods, like those in pulsars (typical period $\sim .3 \text{ sec}$), can be measured.

III. TYPES OF JOSEPHSON DEVICES

There is a large diversity of geometries that exhibit the Josephson effects. In this section, we discuss some of the most common of these.

a) *Cross-wire junction*

This junction is made by pressing together two superconducting wires (usually Nb, due to its mechanical strength) that have been heat-treated to produce a layer of oxide on their surface. This oxide layer acts as the insulator between superconductors. In practice, however, the oxide layer is not perfect and the presence of micro-shorts between the superconductors causes a weak link behavior in this type of device, rather than a true

junction. It presents serious drawbacks to its practical use as a detector. First: although it is relatively simple to fabricate, on recycling it changes its characteristics very drastically, due to differential contraction in the metal and insulator holder that keeps a constant pressure on the wires. Second: it is very difficult to couple radiation to the sensitive area; hence yielding a large N.E.P. The best N.E.P. we were able to obtain using this type of weak link was of the order of $10^{-12} \text{ watt } \sqrt{\text{Hz}}$.

b) *Solder-blob junction*

This type is, again, very simple to fabricate. One only has to deposit a drop of standard Sn/Pb solder on a heat-treated superconducting wire (Nb). At low temperatures, the solder is also a superconductor and the oxide layer on the wire acts as an insulator. The blob-type weak link is very stable, has excellent recycling properties, and is very sensitive to changes in biasing current or voltage (Clarke 1970). As such, it has been successfully used in building superconducting galvanometers (SLUG). However, from the point of view of a radiation detector, it presents a very serious problem. Radiation cannot penetrate the solder drop and reach the sensitive junction. The only possible scheme to couple the weak link to radiation is via an inductive coupling of the superconducting wire, *i.e.*, letting it act as an antenna. To our knowledge, this coupling scheme has not been fully explored.

c) *Tunnel or SIS junction*

This type of junction is made by depositing two thin film strips, approximately 1 mm. wide and 1000 Å thick, on a substrate forming a cross, and oxidizing the first one. Therefore in the overlapping region of the two strips, one has a Superconductor-Insulator-Superconductor sandwich. This device exhibits true Josephson junction behaviour. However, the S-I-S sandwich has a large capacitance, thus presenting a large reactive mismatch at large frequencies and reflecting most of the incident radiation. One way to overcome this problem is to make the thin film strips much narrower (*v.g.* 20 microns). The capacitance depends on the area of the sandwich; hence on the square of the factor by

which we reduce the width of the film strips. The technical problems involved in making such narrow film strips have been overcome (McCarthy and Warman 1974) via electron-beam fabrication techniques. However, there remains to be tested the sensitivity and recycling properties of these narrow tunnel junctions.

d) *Powder junction*

This type of junction has been extensively studied by the author and the results have been reported (Warman 1972; Warman, Jahn and Kao 1971). The device is made by pressing together a large number (10000) of superconducting small grains (av. diam. ~ 45 microns). The resulting detector can be highly sensitive; in fact, we have obtained N.E.P.'s as low as $10^{-14} \text{ W}/\sqrt{\text{Hz}}$. However, from the point of view of a practical detector, their reliability is poor. A more reliable detector, based on the same principle, has been extensively studied by T.D. Clark (1968). Yet, the properties of this type of junction are quite complex and their practical application remains to be studied.

e) *Point-Contact junction*

This junction is made by pressing a pointed superconducting wire (the point is made by filing or etching) against a flat superconducting surface. Typical materials are Nb-Sn, Ta-Sn, and Pb-Sn or Pb-Pb. The only detector system that has been applied to Astronomy makes use of this type of weak link (Ulrich 1974). The detector has been successfully used in observing at 1 mm and 2 mm wavelengths at McDonald Observatory. Although the I-V characteristics remain constant only up to 10% through recycling, nightly calibration can overcome this problem. Sensitivities of point contact devices range in the $10^{-13} \text{ W}/\sqrt{\text{Hz}}$ N.E.P. range. A complete description of the detector system can be found in the above-mentioned reference.

f) *Superconducting bridges*

Another geometry of interest, from the point of view of a radiation detector, is a superconducting bridge; *i.e.*, a small and narrow thin film, connecting two "bulk" superconductors (usually two large

films). Phase correlation of the two bulk superconductors takes place through the bridge. An obvious attractive feature of this geometry is its mechanical stability, since once the film is deposited, it requires no further mechanical contact. Also, this geometry allows the preparation of clean samples, whose dimensions can be controlled. Finally, from the point of view of coupling to electromagnetic radiation, the bridge offers an "open" geometry; *i.e.*, the sensitive area of the device is not surrounded by superconducting material. This should improve the efficiency of the coupling.

The first experiments with superconducting bridges in an electromagnetic field were reported by Dayem and Anderson (Dayem and Anderson 1964). Their bridges were deposited using a mask and were $\sim 4 \times 2 \mu\text{m}$ in size. With applied radiation, they observed the presence of both harmonic and subharmonic steps, but the behavior of the bridge was not "Josephson-like" except very near the critical temperature.

In these bridges, sensitivity to radiation was rather poor. More recent work indicates (Warman 1972) that the range of temperatures in which the bridge shows Josephson behavior, could be extended by making smaller bridges.

To understand this behavior, it is convenient to reconsider briefly the basic Josephson relations. These are

$$I = I_0 \sin \Phi \quad (2)$$

and

$$\Delta\mu = \hbar\Phi \quad (18)$$

$\Delta\mu$ being the change in chemical potential across the weak link. Clearly, taking $\Delta\mu = 2eV$ reduces the equation to its previous form. However, the point is that these equations are fundamentally different. Eq. (18) is valid for any chemical potential change in a superconductor, and is derived only from symmetry considerations on the complex order parameter, while Eq. (2) determines whether the superconductor shows Josephson behavior. (In order to avoid confusion, due to semantics, we specify "pure" Josephson behavior as the situation in which the current-phase Equation (2) is strictly satisfied). The dependence of the current-phase relation on the length of the bridge (more precisely, on the ratio of the length of the bridge and the coherence

length) has been studied theoretically by Baratoff *et al.* (1970), and independently by Christiansen *et al.* (1971). Baratoff takes a one-dimensional superconducting wire in which a section of length L has a smaller critical current. The solutions of the one-dimensional Ginzburg-Landau equations on this region, are found and fitted continuously (together with the derivatives) to the solutions in the rest of the wire. From these solutions, the current-phase relation can be obtained for the "weak" superconducting region. The results indicate that the current-phase relation is sinusoidal only when $L/\xi \ll 1$, and as L increases (or ξ decreases) the I - Φ curve becomes skew towards higher values of the argument. In the limit of very large L , even the periodic nature of $I(\Phi)$ is lost. Similar results were obtained by Christiansen, through a very different argument. He solved the one-dimensional Ginzburg-Landau equations for a small link connecting two large superconductors (using rigid boundary conditions at the end of the link), and redefined the phase as

$$\delta = \Phi + \alpha L_M, \quad (19)$$

where Φ is the usual phase, δ the redefined phase, L_M the self-inductance of the link, and α a parameter that depends on the temperature through the coherence length. For temperatures near T_c , the L_M contribution is negligible and one recuperates the sinusoidal I - Φ relation. However, when the coherence length becomes smaller, L_M contribution becomes important and, again, the I - Φ curve becomes skewed toward higher values of Φ . An attractive feature of the Christiansen model is that it allows for a difference in the critical temperature of the weak link and that of the bulk superconductors; while Baratoff's model assumes the same critical temperature for the link and the bulk.

The first experimental study of the current-phase relation was made by Fulton and Dynes (1970) and confirms the departure from the sinusoidal form as the temperature departs from T_c . A more recent study, made by Song (1972) on the effect of the ratio L/ξ on the behavior of a weak link, confirms the fact that near T_c ($L/\xi \ll 1$) the link shows Josephson behavior; while at low temperatures ($L/\xi \gg 1$), the link behaves as a "bulk" superconductor.

In the presence of an r-f field, the superconducting bridges manifest a unique behavior. This is an enhancement of the zero voltage current. Instead of following the Bessel function behavior under an increasing r-f field, the zero voltage current increases first. The effect was first studied by Dayem and Wiegand in 1964. Its importance for detection is evident, since (in the broadband mode) it is the behavior in the presence of small amounts of incident radiation that controls the response of the detector.

A probable explanation of the microwave enhancement of the critical current is due to Eliashberg (1970) and is based on the idea that, under certain conditions, an r-f field shifts the "center of gravity" of the excitations distribution function towards larger values of the energy, thereby increasing the ordering parameter Δ , through the equation

$$\Delta = g \int_{\Delta}^{k_{WD}} d\varepsilon \frac{\Delta}{\sqrt{\varepsilon^2 - \Delta^2}} (1 - 2n(\varepsilon)), \quad (20)$$

where in equilibrium $n(\varepsilon) = 1/(1 + \exp(\varepsilon/T))$. More explicitly, for the case of a thin film in the dirty limit, Eq. (20) can be taken to the form

$$(\alpha - \beta^2 \Delta^2 - \gamma - \delta \psi) \Delta = 0, \quad (21)$$

where

$$\alpha = 1 - T/T_c$$

$$\beta^2 = \frac{7 \xi(3)}{8 (\pi T_c)^2} \quad (22)$$

$$\gamma = \frac{\pi}{6 T_c} \frac{l v e^2}{\hbar c^2} A_0^2$$

$$\delta = \frac{\pi}{6 T_c} \frac{l v e^2}{\hbar c^2} \frac{A_\omega^2}{2}$$

Where T_c is the critical temperature, A_0 takes into account the effect of static magnetic field and currents, and A_ω that of alternating fields. Also,

$$\Psi = 1 - \frac{\hbar \omega}{2 \pi \eta} f\left(\frac{\hbar \omega}{\Delta}\right) \quad (23)$$

$$\eta = \hbar / \tau_0,$$

where τ_0 is the lifetime of the excitations, and f is a complicated function, whose asymptotic behavior is given by

$$f(u) = u \ln(8/u), u \ll 1, \quad (24)$$

$$f(u) = \pi/u, u \gg 1:$$

We notice first that for microwave radiation, $\hbar\omega/\Delta \ll 1$, so

$$f\left(\frac{\hbar\omega}{\Delta}\right) = \frac{\hbar\omega}{\Delta} \ln \frac{8\Delta}{\hbar\omega} \quad (25)$$

substituting (25) in (23),

$$\psi = 1 - \frac{\hbar^2 \omega^2}{2\pi\gamma\Delta} \ln \frac{8\Delta}{\hbar\omega} \quad (26)$$

Two facts become apparent from this equation:

i) There exists a critical frequency, ω_c , such that

$$\omega_c^2 \ln \frac{8\Delta}{\hbar\omega} = \frac{2\pi}{\hbar^2} \gamma \Delta$$

for frequencies under ω_c , $\psi > 0$ while if $\omega > \omega_c$, $\psi < 0$. ii) $\psi(\Delta)$ approaches rapidly its asymptotic value and there exists a wide range of Δ values for which $\psi(\Delta)$ is essentially independent of Δ . In this region, Eq. (21) can be solved as a quadratic equation whose positive root is given by

$$\Delta = \frac{1}{\beta} (\alpha - \gamma - \delta\psi)^{1/2} \quad (27)$$

From this equation, one can make some qualitative predictions. i) An r-f field of frequency $\omega > \omega_c$ will induce an increase in Δ ; hence in the maximum zero voltage current. ii) A magnetic field depresses the value of Δ , yet, for each magnetic field, the enhancement of the critical current takes place. iii) For a given intensity of the r-f field, the increase in Δ will be larger for higher frequencies. Clearly, the frequencies cannot be too high or approximation (25) breaks down. This frequency effect has been observed by Dayem (1967). iv) The presence of an r-f field will enhance the critical temperature. Such an effect was studied by Wyatt

and Evans (1969), although it was interpreted as due to some type of unspecified fluctuations.

IV. EXPERIMENTAL SET UP

Whatever the type of weak link being used, the experimental set-up is basically the same. The system we describe in the following paragraphs, is the one employed by the author in the study of three types of junctions; crossed wires, powder, and microbridges. Figure 4 shows the schematics of the physical set-up for laboratory tests. The basic parameters that control the behaviour of the junction are the temperature, magnetic field, and incident radiation. Hence, we immerse the junction in a LHe bath, in such a way that it is located in the center of an homogeneous magnetic field, and we provide a light pipe (or wave guide) system, with a chopper, to guide the incident radiation.

Figure 5 shows a block diagram of the measuring circuit. A voltage source S , in series with the variable resistor P (0 to 50 k Ω), acts as a current source

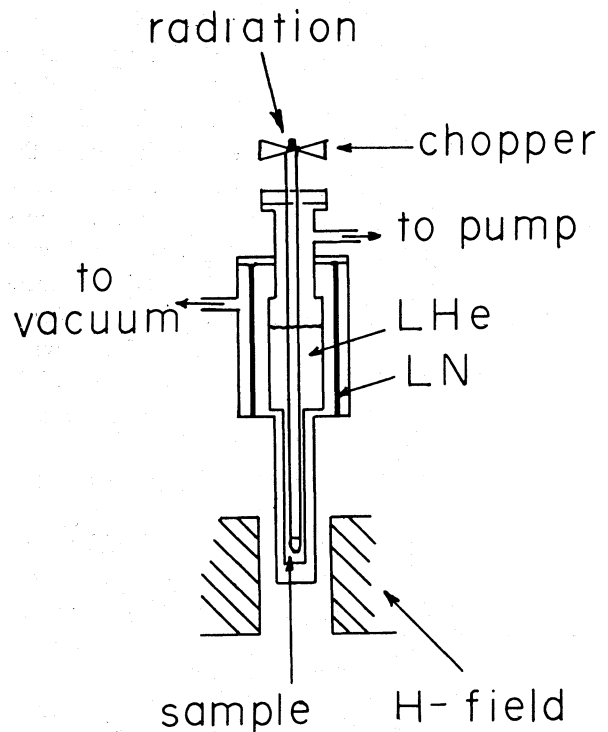


FIG. 4. Schematic diagram of the cryogenic system.

for the junction. The current is measured in the I channel by the voltage across R . Having $R = 100\Omega$ insures that the circuit acts as a current source for any value of P . The junction is considered a four terminal device and the V channel uses a differential input to measure the voltage across the junction. For testing, a function generator is used in place of S and is operated at any convenient frequency (~ 500 Hz). The I and V channels are the Y and X inputs (differential) of a Dual Beam Oscilloscope. In order to obtain I-V curves, the function generator can be operated in the sawtooth mode at a very low frequency (.1Hz). I - channel is then the Y input of a X-Y recorder, while voltage is measured by a D.C. microvoltmeter, whose output goes to the X channel of the recorder.

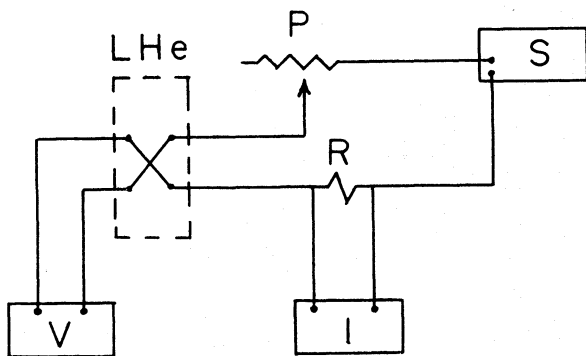


FIG. 5. Block diagram of the measuring system. Junction is shown as a four terminal device.

The sensitivity measurements are carried out with a D.C. voltage source as a bias. Radiation is amplitude-modulated and the voltage across the junction measured with the lock-in amplifier operating at the modulation frequency. A convenient value for this frequency was ~ 1 KHz. Usually, input impedances of the lock-in amplifier are high ($10M\Omega$), while the impedance of the junction is quite small (typically $.1\Omega$). Hence, a matching transformer provides a first stage of amplification between the junction and the amplifier. The exact gain of these transformers depends on the impedance across their primary windings. Rather than determine this value for each bias current and compute the exact gain, we prefer to consider, for the purposes of sensitivity, junction and transformer as one unit and to compute

the responsivity of the detector as the ratio of the voltage read at the lock-in and the power input.

The radiation detection tests in our experiments were carried out, almost without exception, in the microwave range. This was due to the availability of microwave equipment and the relative difficulty of obtaining infrared test equipment. An r-f generator, together with a frequency doubler, provided a versatile microwave source, covering the frequency ranges from 8.2 to 12.4 KMHz and from 16.4 to 24.8 KMHz. Attenuators allowed us to vary the power incident on the junction from 10^{-4} to 10^{-15} W.

a) Calibration

We have mentioned the fact that, in principle, a weak link has a very wide frequency response range. In practice, however, one must choose a frequency range of operation which is much narrower. In the broadband mode, this is equivalent to using filters. That is, the use of a given size waveguide (or light pipe) determines a range of operation, the same as it can transmit with minimum loss. A narrower range can be obtained by coupling into a cavity (Ulrich 1974). One must take into account all these coupling factors in the determination of an intrinsic N.E.P. figure.

Calibration can be made in several ways. One can compute the absolute amount of energy being sent into the waveguide by knowing the temperature of the emitting source (assuming it to be a black-body) and the spectral response of the detector system. Measuring then the response to that amount of energy gives a calibration directly in energy units. Alternatively, one can use as sources of radiation two black-bodies at known temperatures, and by measuring the relative response, get a calibration in temperature units. This last method is widely used in radioastronomy.

b) Microbridges

Our samples were prepared by the method suggested by Gregers-Hansen *et al.* (1971). A glass substrate is cleaned ultrasonically and washed in distilled water, acetone, and methanol. A first scratch is then made with a razor blade (tungsten stainless steel edge seems to give best results). A film of tin

is evaporated on the substrate, with a thickness of ~ 1000 Å. A second scratch, perpendicular to the first, is made to remove all the tin except the one deposited in the furrow made by the first cut, constituting the bridge. By this method, one can obtain bridges of good quality and approximately $.5 \times 1 \mu\text{m}$ in size. However, the method has three severe drawbacks: i) The yield of good bridges is very low, $\sim 2\%$. ii) One cannot decide the size of the bridge prior to its fabrication. iii) The shape of the bridge is only approximately known. Furthermore, the edges of the bridge are not well defined and the debris left by the blade makes them uneven. This feature is important because the current density will be larger at the edges. If they are irregular, they will form a superconductor "weaker" than the bridge, thus the properties of the bridge will be really determined by those of the edges.

Figure 2 shows the I-V characteristic of one of our samples and the effect of incident microwave radiation. We note the presence of both harmonic and subharmonic series.

From the point of view of sensitivity, the entire theory applies without change to the narrow-band modes, and the theoretical estimates of ultimate sensitivity are the same. For the broadband mode, a theoretical estimate cannot be made without a better understanding of the Dayem effect. We have obtained experimentally sensitivities $\sim 10^{-12} \text{ W}/\text{Hz}$. An improvement of this number depends on the possibility of fabricating cleaner and smaller samples. The need of these cleaner samples is also evident if one is to understand more clearly the Dayem Effect. With this motivation, we endeavored to improve the method of fabrication of microbridges. We have now been able to overcome most of the technical difficulties involved in making small, clean, and reproducible bridges by making use of electron-beam techniques. These techniques were first developed by the IBM group (Broers and Hatzakis 1970) and were adapted to the fabrication of small microbridges (McCarthy and Warman 1974). Now we have open several interesting possibilities: first, of course, the fabrication of microbridges in a reproducible manner, with their possible application to detection once a better understanding of the Dayem effect is achieved. Second, the possibility of making the narrow crossfilm tunnel junction. Third, the

possibility of making narrow overlay-microbridges (Notary's bridges) of a previously unachieved size. This program is now being advanced.

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